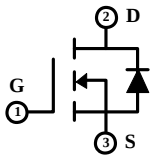
10A 600V N-channel Enhancement Mode Power MOSFET

1 Description

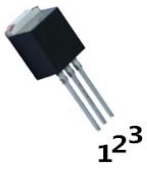
These silicon N-channel Enhanced VDMOSFETs, is obtained by the self-aligned planar technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. Which accords with the RoHS standard.



V_{DSS} = 600V

$R_{DS(on)(TYP)}$= 0.68Ω

I_D = 10A



TO-262

2 Features

- Fast Switching
- Low ON Resistance(Rdson≤0.9Ω)
- Low Gate Charge(Typical Data:32nC)
- Low Reverse Transfer Capacitances(Typical:7.5pF)
- 100% Single Pulse Avalanche Energy Test
- 100% ΔV_{DS} Test

3 Applications

- Used in Various Power Switching Circuit for System Miniaturization and Higher Efficiency.
- Power Switch Circuit of Adaptor and Charger.

4 Electrical Characteristics

4.1 Absolute Maximum Rating (Tc=25℃,unless otherwise noted)

Parameter		Symbol	Value	Units
Maximum Drian-Source DC Voltage		V_{DS}	600	V
Maximum Gate-Drain Voltage		V_{GS}	±30	V
Drain Current(continuous)		I_D（T=25℃）	10	A
		（T=100℃）	6.3	A
Drain Current(Pulsed)(Note 1)		I_{DM}	40	A
Single Pulse Avalanche Energy(Note 5)		E_{AS}	580	mJ
Peak Diode Recovery dv/dt(Note 6)		dv/dt	5	V/ns
Total Dissipation	T_a=25℃	P_{tot}	2	W
	T_C=25℃	P_{tot}	130	W
Junction Temperature		T_j	150	℃
Storage Temperature		T_{stg}	-55～150	℃
Maximum Temperature for soldering		T_L	300	℃

4.2 Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance Junction to Case-sink	R_{thJC}	0.96	℃/W
Thermal Resistance Junction to Ambient	R_{thJA}	62.5	℃/W

4.3 Electrical Characteristics(Tc=25℃,unless otherwise noted)

Parameter	Symbol	Test Condition	Value			Units
			Min	Typ	Max	
Off Characteristics						
Drain-source Breakdown Voltage	BV_{DSS}	I_D=250μA,V_{GS}=0V	600	--	--	V
Drain-to-Source Leakage Current	I_{DSS}	V_{DS}=600V,V_{GS}=0V,T_C=25℃	--	--	1	μA
		V_{DS}=480V,V_{GS}=0V,T_C=125℃	--	--	100	μA
Gate-to-Source Forward Leakage	I_{GSSF}	V_{GS}=+30V	--	--	100	nA
Gate-to-Source Reverse Leakage	I_{GSSR}	V_{GS}=-30V	--	--	-100	nA
On Characteristics(Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS},I_D=250μA	2	--	4	V
Drain-source on Resistance	$R_{DS(on)}$	V_{GS}=10V,I_D=5A	--	0.68	0.9	Ω
Dynamic Characteristics(Note 4)						
Forward Transfer Conductance	g_{fs}	V_{DS}=15V,I_D=5A	--	9.5	--	S
Input Capacitance	C_{iss}	V_{GS}=0V,V_{DS}=25V,f=1.0MHz	--	1609	--	pF
Output Capacitance	C_{oss}		--	136	--	
Reverse Transfer Capacitance	C_{rss}		--	7.5	--	
Switching Characteristics(note4)						
Turn-on Delay Time	$t_{d(on)}$	I_D=10A, V_{DD}=300V, R_G=10Ω	--	26	--	nS
Turn-on Rise Time	t_r		--	23	--	nS
Turn-off Delay Time	$t_{d(off)}$		--	49	--	nS
Turn-off Fall Time	t_f		--	27	--	nS
Total Gate Charge	Q_g	I_D=10A,V_{DD}=480V,V_{GS}=10V	--	32	--	nC
Gate-to-Source Charge	Q_{gs}		--	8	--	
Gate-to-Drain("Miller") Charge	Q_{gd}		--	12	--	
Drain-Source Diode Characteristics						
Diode Forward Voltage(Note 3)	V_{FSD}	V_{GS}=0V,I_S=10A	--	--	1.5	V
Diode Forward Current(Note 2)	I_S		--	--	10	A

Reverse Recovery Time	t_{rr}	T_J=25℃,I_S=10A, dI_F/dt=100A/μS,V_{GS}=0V	--	499	--	nS
Reverse Recovery Charge	Q_{rr}		--	2940	--	nC
Reverse Recovery Current	I_{RRM}		--	11.8	--	A

Notes：

1: Repetitive rating, pulse width limited by maximum junction temperature.

2: Surface mounted on FR4 Board, t≤10sec.

3: Pulse width ≤ 300μs, duty cycle ≤ 2%.

4: Guaranteed by design, not subject to production.

5. L=10mH,I_D=10.8A, Start T_J=25℃.

6. I_{SD}=10A,di/dt≤100A/μs,V_{DD}≤BV_{DSS}, Start T_J=25℃.

5 Typical characteristics diagrams

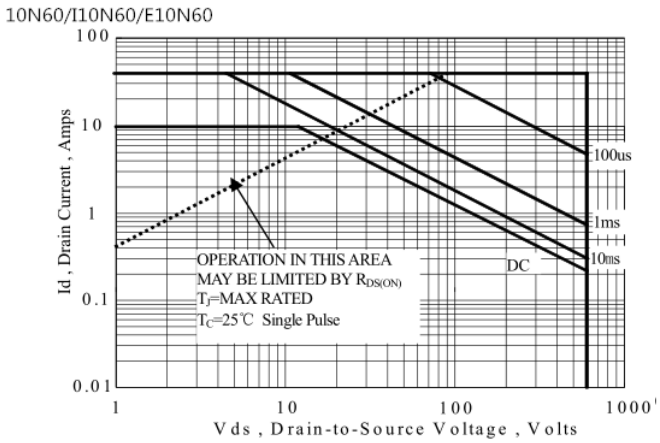


Figure 1 Maximum Forward Bias Safe Operating Area

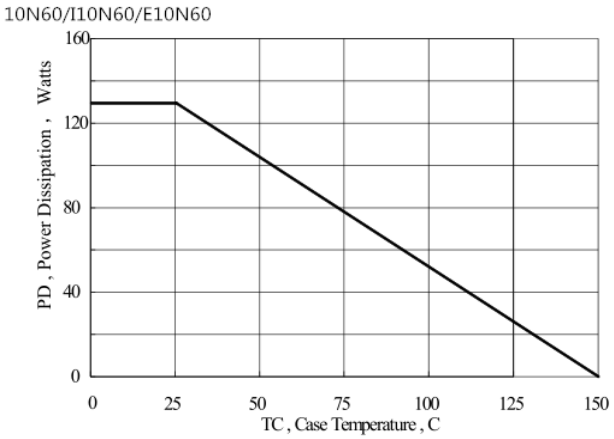


Figure 2 Maximum Power Dissipation vs Case Temperature

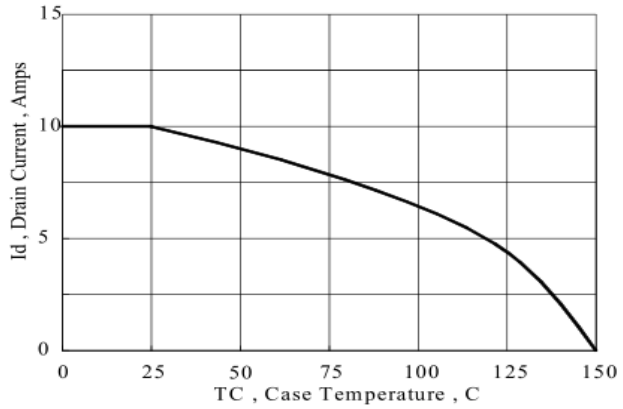


Figure 3 Maximum Continuous Drain Current vs Case Temperature

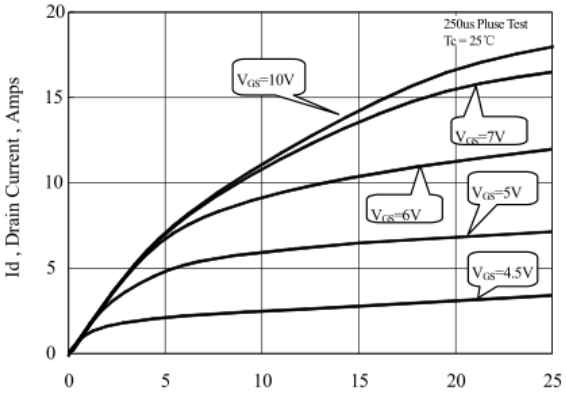


Figure 4 Typical Output Characteristics

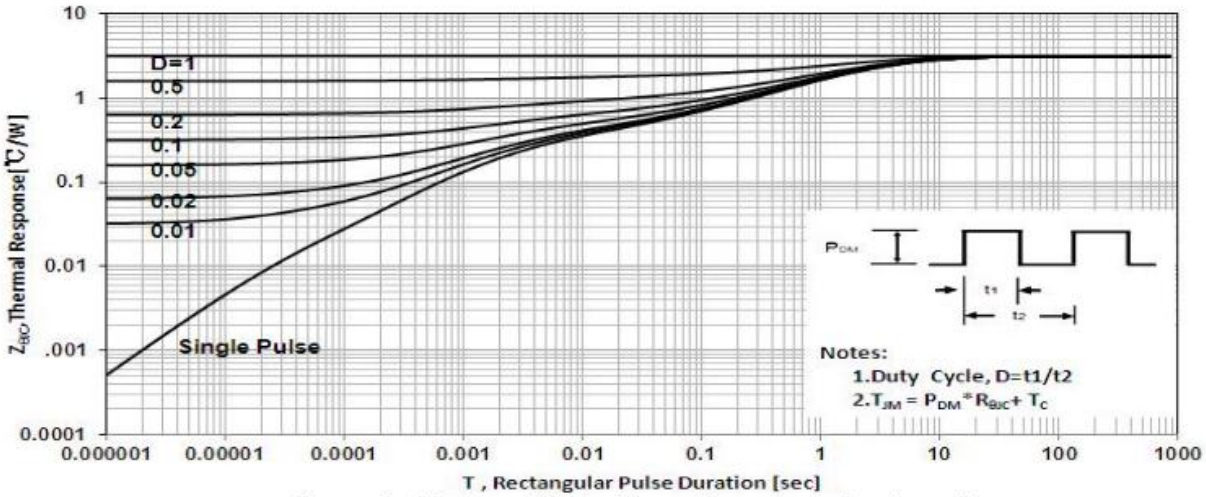


Figure 5 Maximum Effective Thermal Impendance , Junction to Case

5 Typical characteristics diagrams(continues)

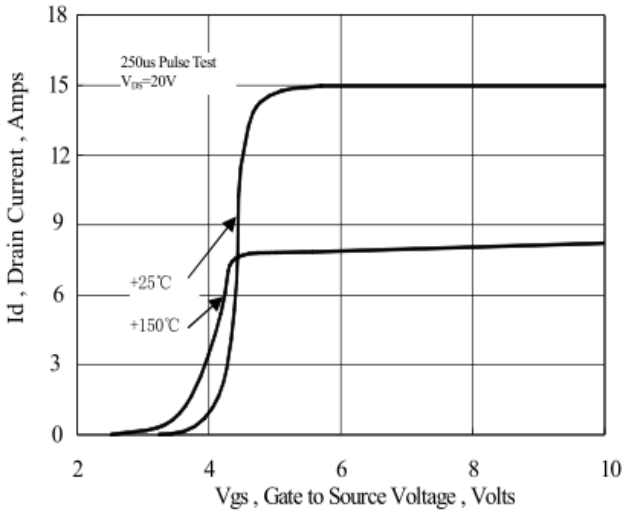


Figure 6 Typical Transfer Characteristics

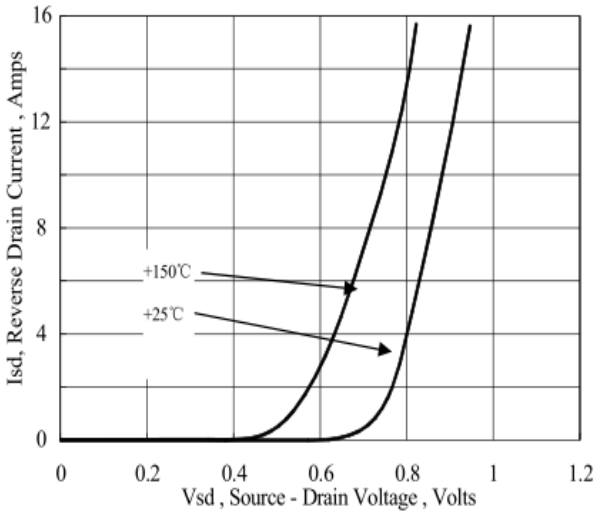


Figure 7 Typical Body Diode Transfer Characteristics

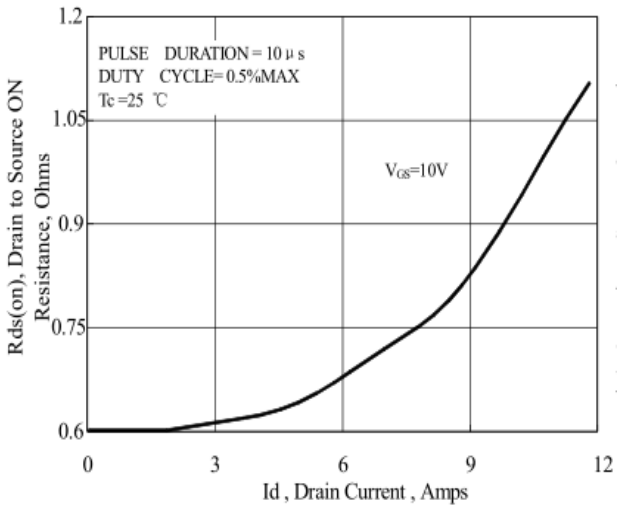


Figure 8 Typical Drain to Source ON Resistance vs Drain Current

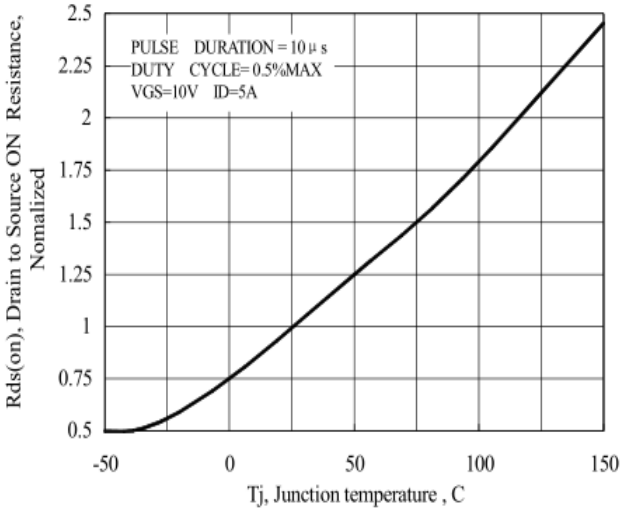


Figure 9 Typical Drian to Source on Resistance vs Junction Temperature

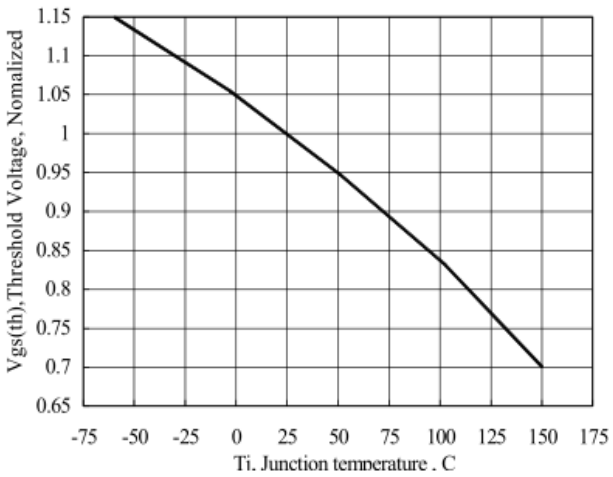


Figure 10 Typical Theshold Voltage vs Junction Temperature

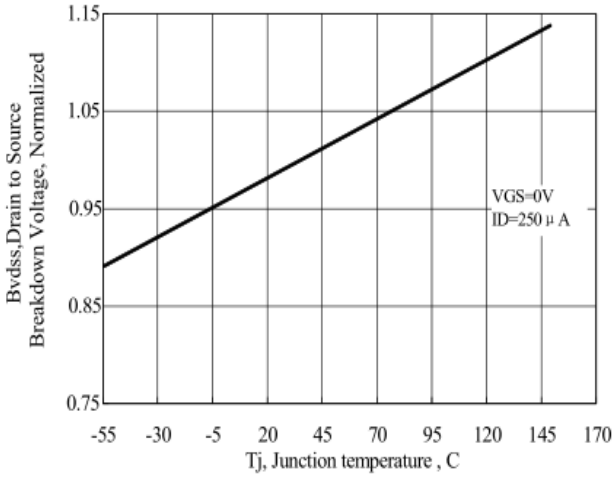


Figure 11 Typical Breakdown Voltage vs Junction Temperature

5 Typical characteristics diagrams(continues)

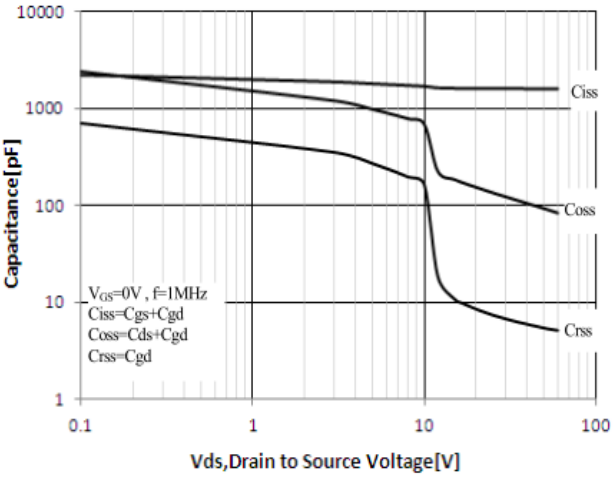


Figure 12 Typical Capacitance vs Drain to Source Voltage

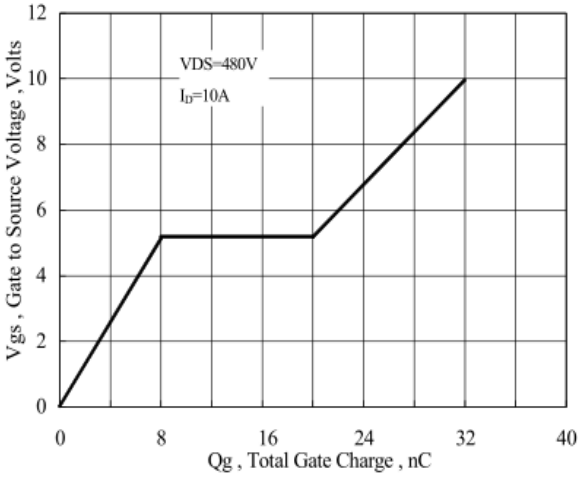


Figure 13 Typical Gate Charge vs Gate to Source Voltage

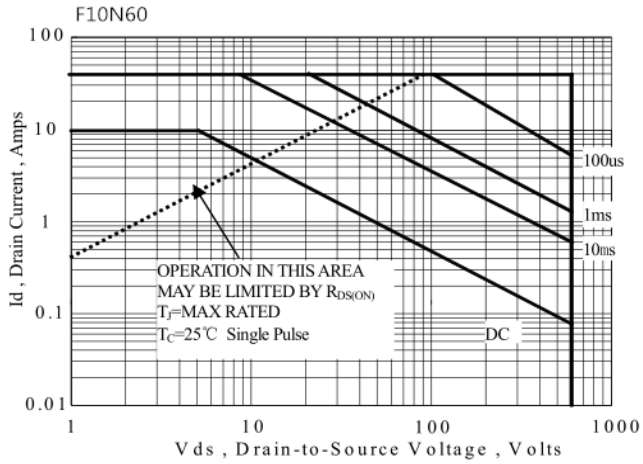


Figure 14 Maximum Forward Bias Safe Operating Area

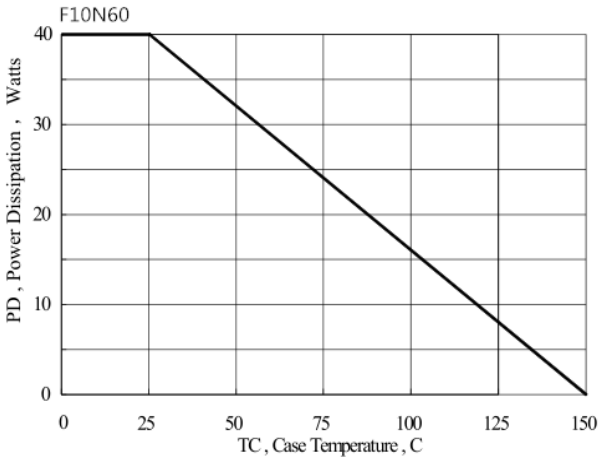
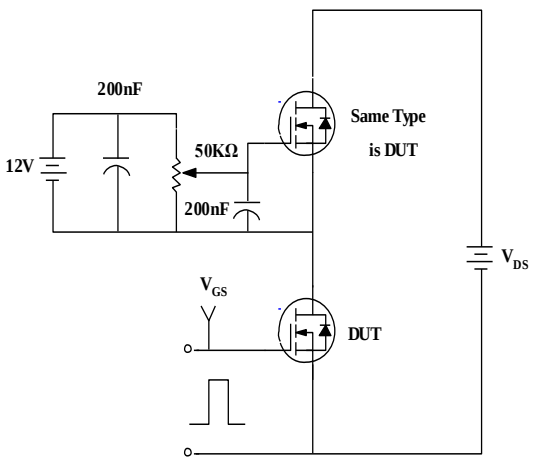
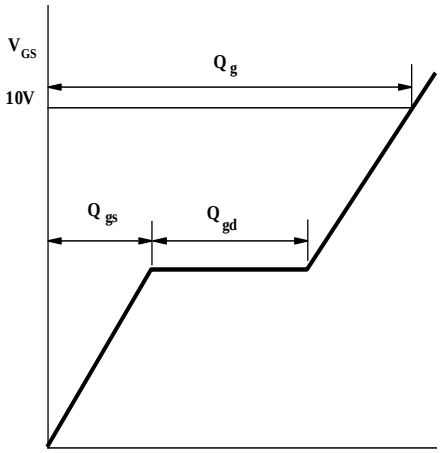


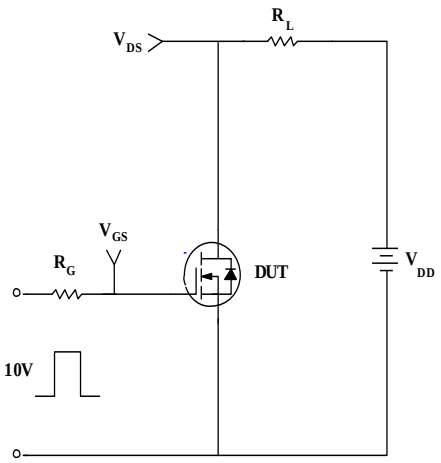
Figure 15 Maximum Power Dissipation vs Case Temperature

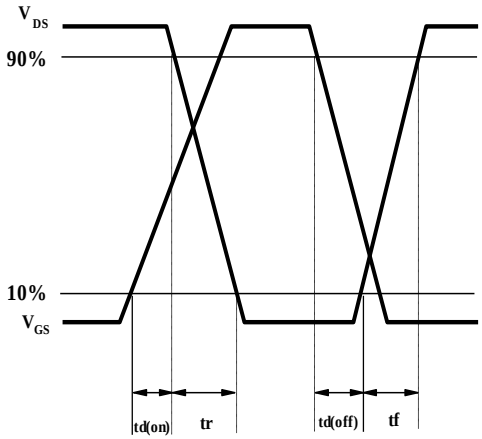
6 Typical Test Circuit and Waveform



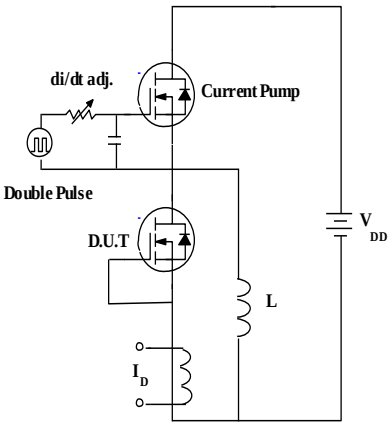


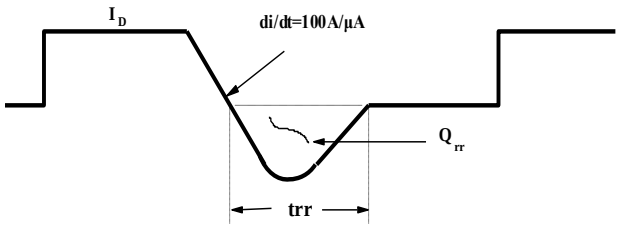
1) Gate Charge Test Circuit & Waveform





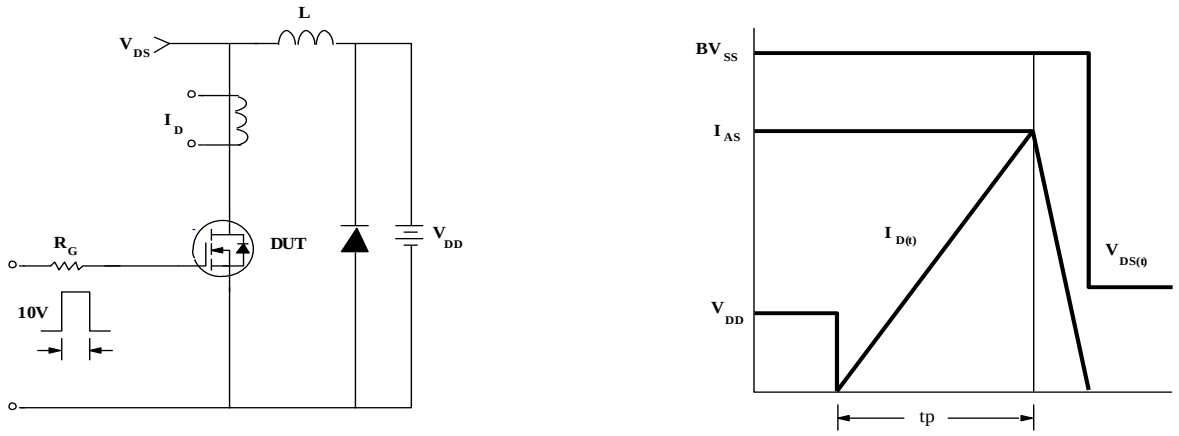
2) Resistive Switching Test Circuit & Waveforms





3) Diode Reverse Recovery Test Circuit & Waveform

6 Typical Test Circuit and Waveform(continues)



4) Unclamped Inductive Switching Test Circuit & Waveforms

7 Product Names Rules

F X X N E X X

Packaging Code
220F: F 220: Nothing
251: B 252: D
262: I 263: E

Rated Voltage Code
With 2 Digital,For Example:
60 on behalf of 600V,
06 on behalf of 60v

Rated Current Code
With 1-2 Digital,
For Example:
4 on behalf of 4A,
10 on behalf of 10A,
08 on behalf of 0.8A

Special Function Code
E on behalf of build-in ESD
Nothing on behalf of not ESD

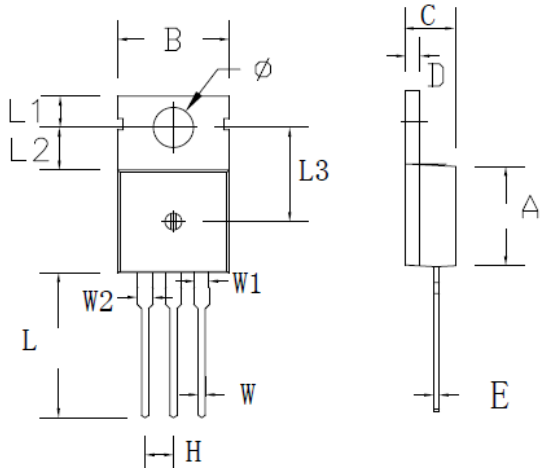
Channel Polarity Code
N on behalf of N channel
P on behalf of P channel

8 Product Specifications and Packaging Models

Product Model	Package Type	Mark Name	RoHS	Package	Quantity
10N60	TO-220C	10N60	Pb-free	Tube	1000/box
F10N60	TO-220F	F10N60	Pb-free	Tube	1000/box
I10N60	TO-262	I10N60	Pb-free	Tube	1000/box
E10N60	TO-263	E10N60	Pb-free	Tape & Reel	800/box

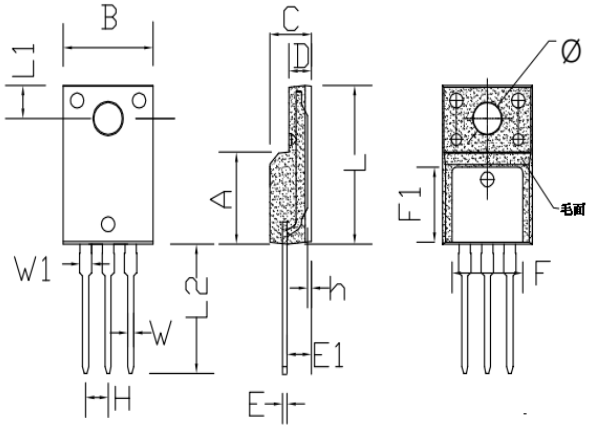
9 Dimensions

TO-220C PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	9.70	10.30	0.382	0.406
C	4.25	4.75	0.167	0.187
D	1.20	1.45	0.047	0.057
E	0.40	0.60	0.016	0.024
H	2.54 TYP		0.100 TYP	
W	0.60	0.95	0.024	0.037
W1	1.05	1.45	0.041	0.057
W2	1.20	1.60	0.047	0.063
L	12.60	13.40	0.496	0.528
L1	2.45	2.95	0.096	0.116
L2	3.45	3.95	0.136	0.156
L3	8.15	8.65	0.321	0.341
Φ	3.50	3.90	0.138	0.154

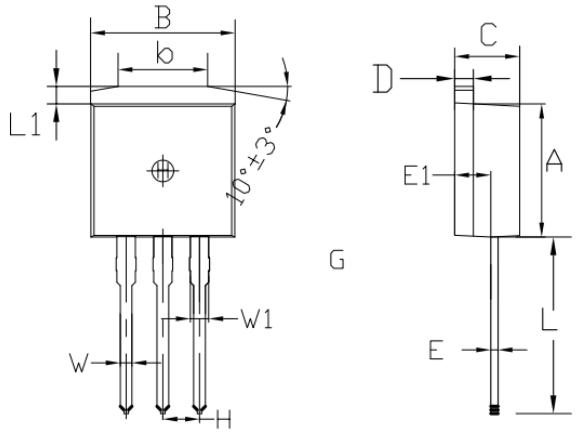
TO-220F PACKAGE OUTLINE DIMENSIONS



Symbol	DimensionsIn Millimeters		DimensionsIn Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	10.00	10.50	0.394	0.413
C	4.30	4.90	0.169	0.193
D	2.30	2.70	0.091	0.106
L	15.55	16.15	0.612	0.636
h	0.40	0.60	0.016	0.024
L1	3.15	3.55	0.124	0.140
L2	12.65	13.35	0.498	0.526
W	0.70	0.90	0.028	0.035
W1	1.15	1.55	0.045	0.061
H	2.54 TYP		0.100 TYP	
E	0.48	0.53	0.019	0.021
ϕ	2.90	3.40	0.114	0.134
E1	2.40	2.90	0.094	0.114
F	7.75	8.25	0.305	0.325
F1	7.35	7.85	0.289	0.309

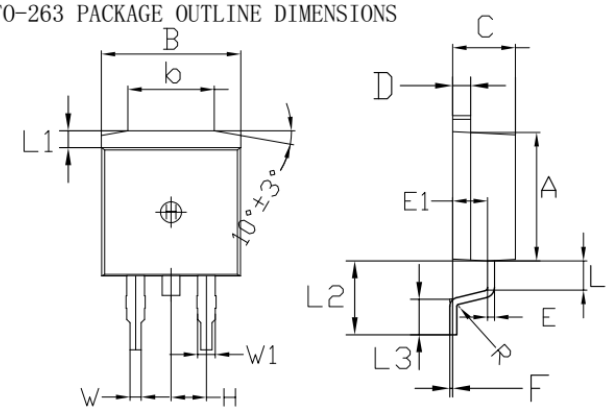
9 Dimensions(continues)

TO-262 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	9.70	10.30	0.382	0.406
C	4.25	4.75	0.167	0.187
D	1.20	1.45	0.047	0.057
E	0.40	0.60	0.016	0.024
L	12.25	13.75	0.482	0.541
L1	1.15	1.45	0.045	0.057
E1	2.4	2.6	0.0945	0.1024
W	0.80	0.82	0.0315	0.034
W1	1.20	1.30	0.047	0.051
H	2.54 TYP		0.200 TYP	
b	5.50	6.50	0.216	0.256

TO-263 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	9.70	10.30	0.382	0.406
C	4.25	4.75	0.167	0.187
D	1.20	1.45	0.047	0.057
E	0.40	0.60	0.016	0.024
L	1.90	2.30	0.075	0.091
L1	1.15	1.45	0.045	0.057
R	0.24	0.26	0.0095	0.0102
W	0.80	0.82	0.0315	0.0323
W1	1.20	1.30	0.047	0.051
H	2.54 TYP		0.200 TYP	
b	5.50	6.50	0.216	0.256
E1	2.4	2.6	0.0946	0.1024
L2	5.20	5.80	0.205	0.228
L3	2.20	3.20	0.087	0.126
F	0.03	0.23	0.0012	0.0091

10 Attentions

- ROUM Semiconductor Technology CO.,LTD. reserves the right to change the specification without prior notice! The customer should obtain the latest version of the information before making the order and verify that the information is complete and up to date.
- It is the responsibility of the purchaser for any failure or failure of any semiconductor product under certain conditions. It is the responsibility of the purchaser to comply with safety standards and to take safety measures in the system design and machine manufacturing of Roma products in order to avoid potential risk of failure. Injury or property damage.
- Product promotion is endless, our company will be dedicated to provide customers with better products.

11 Appendix

Revision history:

Date	REV.	Description	Page
2017.04.01	1.0	Original	